Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/656,182	MCTEER, ALLEN	
Examiner	Art Unit	
Fugene Lee	2815	

SEARCHED			
Class	Subclass	Date	Examiner
257	770,774	6/24/2005	EL
257	762-764	6/24/2005	EL

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	·			
	1			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
searched EAST, USPAT, JPO, EPO	6/24/2005	EL .
EIC search, discussed with Jeff Harrison	3/7/2005	EL
discussed with George Eckert	3/16/2005	EL